



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017
& ANSI/NCSL Z540-1-1994

ATLAS WEATHERING SERVICES GROUP
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CALIBRATION

Valid To: August 31, 2024

Certificate Number: 0717.04

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations^{1, 3, 7}:

I. Electrical DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2, 4, 5} (±)	Comments
DC Voltage – Generate	Up to 200 mV (0.2 to 2) V (2 to 20) V (20 to 200) V (200 to 1000) V	0.002 % 0.001 % 0.001 % 0.001 % 0.001 %	Transmille 3010A
DC Current – Generate	Up to 200 uA (0.2 to 2) mA (2 to 20) mA (20 to 200) mA (0.2 to 2) A (2 to 20) A (20 to 30) A	0.02 % 0.01 % 0.01 % 0.01 % 0.01 % 0.03 % 0.04 %	Transmille 3010A

Parameter/Range	Frequency	CMC ^{2, 4, 5} (±)	Comments
AC Voltage – Generate			
100 nV to 202 mV	45 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 500) kHz	0.03 % 0.05 % 1.3 % 1.3 %	Transmille 3010A
(0.2 to 2) V	(10 to 44) Hz 45 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 500) kHz	0.06 % 0.03 % 0.04 % 0.09 % 0.40 %	
(2 to 20) V	(10 to 44) Hz 45 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz	0.06 % 0.02 % 0.03 % 0.08 %	
(20 to 200) V	(30 to 44) Hz 45 Hz to 1 kHz (1 to 10) kHz (10 to 20) kHz	0.06 % 0.03 % 0.03 % 0.05 %	
(200 to 700) V	(30 to 44) Hz 45 Hz to 1 kHz (1 to 10) kHz	0.12 % 0.04 % 0.06 %	

Parameter/Range	Frequency	CMC ^{2, 4, 5} (±)	Comments
AC Current – Generate			
Up to 200 uA	(10 to 44) Hz 45 Hz to 1 kHz (1 to 10) kHz	0.33 % 0.15 % 1.1 %	Transmille 3010A
(0.2 to 2) mA	(10 to 44) Hz 45 Hz to 1 kHz (1 to 10) kHz	0.19 % 0.06 % 0.49 %	
(2 to 20.2) mA	(10 to 44) Hz 45 Hz to 1 kHz (1 to 10) kHz	0.19 % 0.06 % 0.26 %	
(20 to 202) mA	(10 to 44) Hz 45 Hz to 1 kHz (1 to 10) kHz	0.19 % 0.06 % 0.49 %	
(0.2 to 2.02) A	(10 to 44) Hz 45 Hz to 1 kHz (1 to 5) kHz	0.19 % 0.06 % 0.49 %	
(2 to 20) A	(10 to 44) Hz (45 to 100) Hz (0.1 to 1) kHz	0.28 % 0.08 % 0.72 %	
Capacitance – Generate			
1 nF 10 nF	1 kHz	2.3 % 0.26 %	Transmille 3010A

Parameter/Equipment	Range	CMC ^{2, 4, 5} (±)	Comments
Resistance – Generate	0.1 Ω 1 Ω 10 Ω 100 Ω 1 kΩ 10 kΩ 100 kΩ	5.8 % 0.58 % 0.06 % 0.01 % 0.002 % 0.001 % 0.002 %	Transmille 3010A
2 Wire Only	1 MΩ 10 MΩ 100 MΩ 1000 MΩ	0.003 % 0.01 % 0.20 % 0.001 %	
DC Voltage – Measure	100 mV to 1000 V	0.002 %	Fluke 8845A
Resistance – Measure	100 Ω to 100 MΩ	0.01 %	Fluke 8845A
DC Current – Measure	(-100 to -10) nA 10 nA to 100 μA 100 μA to 10 A	0.20 % 0.13 % 0.48 %	Fluke 8845A

Parameter/Range	Frequency	CMC ^{2, 4, 5} (±)	Comments
AC Current – Measure 10 mA to 10 A	10 Hz to 10 kHz	0.55 %	Fluke 8845A
AC Voltage – Measure 100 mV to 750 V	10 Hz to 20 kHz (20 to 50) kHz (100 to 300) kHz	0.11 % 0.29 % 0.66 %	Fluke 8845A

II. Optical Quantities

Parameter/Equipment	Range	CMC ^{2, 4, 6} (\pm)	Comments
Direct Solar Irradiance – Measure			ASTM E816; ISO 9059
Secondary Pyrheliometers	(0.29 to 3.0) μm	0.64 %	Eppley AHF primary cavity pyrheliometer Basis: 1000 W/m ² day
Field Pyrheliometers	(0.29 to 3.0) μm	0.99 %	Secondary pyrheliometer Basis: 1000 W/m ² day
Field Pyranometers	(0.29 to 3.0) μm		ASTM E824; ISO 9847 Group of reference pyranometers (two or more)
	Normal Incidence (31 to 45)° Tilt	0.54 % 1.4 %	Basis: 1000 W/m ² day
Global Solar Irradiance – Measure			ASTM G167; ISO 9846
Reference Pyranometers:	(0.29 to 3.0) μm		Eppley AHF primary cavity pyrheliometer
	Normal Incidence (0 to 45)° Tilt	0.40 % 0.46 %	Basis: 1000 W/m ² day
Spectral Irradiance – Measure			
Spectroradiometers (Normal Incidence to Source)	(0.280 to 0.315) μm (0.280 to 0.400) μm (0.295 to 0.385) μm (0.300 to 0.400) μm (0.315 to 0.400) μm (0.250 to 0.800) μm (0.380 to 1.100) μm	3.6 % 3.6 % 3.6 % 3.5 % 3.5 % 3.7 % 3.6 %	ASTM G138 Standard of spectral irradiance (lamp), OL-752-10E

Parameter/Equipment	Range	CMC ^{2, 4, 6} (±)	Comments
Spectral Irradiance – Measure (cont)			
Reference Ultraviolet Radiometers	(0.280 to 0.315) µm (0.280 to 0.400) µm (0.295 to 0.385) µm (0.300 to 0.400) µm (0.315 to 0.400) µm	4.2 % 3.7 % 3.7 % 3.6 % 3.9 %	ASTM G130 OL 754 Spectroradiometer Basis: 0.2 W/m ² Basis: 70 W/m ² Basis: 60 W/m ² Basis: 70 W/m ² Basis: 70 W/m ²
Field Ultraviolet Radiometer –			ASTM E824; ISO 9847 (Kipp & Zonen UV-S-AB-T & UV-S-A-T (or other) reference UV radiometers
UV-B Ultraviolet Radiometers	(0.280 to 0.315) µm	4.2 %	Basis: 0.2 W/m ²
Total Ultraviolet Radiometers	(0.295 to 0.385) µm	3.7 %	Basis: 60 W/m ²
UV-A Ultraviolet Radiometers	(0.300 to 0.400) µm (0.315 to 0.400) µm	3.6 % 3.9 %	Basis: 70 W/m ² Basis: 70 W/m ²

¹ This laboratory offers commercial calibration service.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ Calibrations are performed under reasonably controlled conditions of clear skies to minimize atmospheric effects, high solar radiance approaching 1000 W/m² to preclude linearity effects and near-normal incidence for all calibrations unless stated otherwise to preclude cosine effects. It should be recognized that the uncertainties associated with the use of carefully calibrated radiometers under the diverse conditions of field use would be significantly higher.

⁴ In the statement of CMC, percentages are to be read as a percentage of the reading unless otherwise noted.

⁵ The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC's are expressed as either a specific value that covers the full range or as a percent or fraction of the reading plus a fixed floor specification.

⁶ The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

⁷ This scope meets A2LA's *P112 Flexible Scope Policy*.



Accredited Laboratory

A2LA has accredited

ATLAS MATERIAL TESTING TECHNOLOGY LLC ATLAS WEATHERING SERVICES GROUP

Phoenix, AZ

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and any additional program requirements in the field of calibration. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 31st day of May 2022.

A blue ink signature of Mr. Trace McInturff.

Mr. Trace McInturff, Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 0717.04
Valid to August 31, 2024
Revised August 25, 2023

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.